

UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE
United States Patent and Tradoraurk Office
Address COMMISSIONER FOR PATENTS
FO. Box 1430
Alexandra, Virginia 22313-1450
www.units.gev

BIBDATASHEET

Bib Data Sheet

CONFIRMATION NO. 6475

Bib Data Sheet										
FILING DATE SERIAL NUMBER 07/31/2003 10/632,273 RULE			CLASS 324		GRO	GROUP ART UNIT 2829		ATTORNEY DOCKET NO. MI22- 2379		
APPLICANTS										
Warren M. Farmworth, Nampa, ID;										
Malcolm Grief, Boise, ID;								•		
This application is a DIV of 10/057,711 01/24/2002 PAT 6,670,819 which is a DIV of 09/411,139 10/01/1999 PAT 6,657,450 which is a DIV of 09/267,990 03/12/1999 PAT 6,380,754 which is a DIV of 08/895,764 07/17/1997 PAT 6,127,195 which is a CON of 08/621,157 03/21/1996 ABN which is a CON of 08/206,747 03/04/1994 PAT 5,523,697 which is a DIV of 08/116,394 09/03/1993 PAT 5,326,428 Checked Rec "FOREIGN APPLICATIONS" IF REQUIRED, FOREIGN FILING LICENSE GRANTED "10/28/2003					•	1				
Foreign Priority claimed	□ yes Ş			STATE OR	SH	HEETS	тс	TAL	INDEPENDENT	
35 USC 119 (a-d) conditions met					DR			AIMS 11	CLAIMS 1	
ADDRESS 021567 WELLS ST. JOHN P. 601 W. FIRST AVEN SPOKANE , WA 99201		· .								
TITLE Method and apparatus operability	s for testing semico	onductor circuitry	for operabil	ity and method of	forming a	apparatus f	or testing	semicono	luctor circuitry for	
						☐ All Fees				
CII NIO CEE	EES: Authority has been given in Paper						6 Fees (Filing)			
	POSIT AC	SIT ACCOUNT			1.17 Fees (Processing Ext. of time) 1.18 Fees (Issue)					
RECEIVED 926	101	o for following:				Other				
						☐ Credit				
L	_									